

<b>Notice of References Cited</b>	Application/Control No. 09/998,400		Applicant(s)/Patent Under Reexamination REED ET AL.	
	Examiner Michael B. Holmes		Art Unit 2121	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,074,426	06-2000	Baumgartner et al.	703/13
*	B	US-5,528,748	06-1996	Wallace, J. Lightsey	714/25
*	C	US-5,481,548	01-1996	Wallace, J. Lightsey	714/712
*	D	US-5,375,126	12-1994	Wallace, J. Lightsey	714/712
*	E	US-4,881,230	11-1989	Clark et al.	714/712
*	F	US-4,873,678	10-1989	Nakamura et al.	369/13.29
*	G	US-4,817,092	03-1989	Denny, Luan J.	714/10
*	H	US-4,750,175	06-1988	Brenneman et al.	370/216
*	I	US-4,792,753	12-1988	Iwai, Kiyoshi	370/244
*	J	US-6,484,062	11-2002	Kim, Hyun	700/90
*	K	US-5,255,211	10-1993	Redmond, Scott	703/6
*	L	US-5,980,256	11-1999	Carmein, David E. E.	434/55
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	Integrating expert system diagnostics within ATE system software Buck, F.L.; AUTOTESTCON '90. IEEE Systems Readiness Technology Conference. 'Advancing Mission Accomplishment', Conference Record. , 17-21 Sept. 1990 Pages:85 - 92			
*	V	Integration techniques for VXibus instrumentation systems Gallagher, A.M.; AUTOTESTCON '90. IEEE Systems Readiness Technology Conference. 'Advancing Mission Accomplishment', Conference Record. , 17-21 Sept. 1990 Pages:183 - 185			
*	W	An experimental conformance test system of home automation system Aoki, T.; Nakatsubo, T.; Minagawa, Y.; Watanabe, Y.; □□Consumer Electronics, IEEE Transactions on , Volume: 34 , Issue: 3 , Aug 1988 Pages:723 - 727			
*	X	Integrated TCP/IP protocol software testing for vulnerability detection Shu Xiao; Lijun Deng; Sheng Li; Xiangrong Wang; □□Computer Networks and Mobile Computing, 2003. ICCNMC 2003. 2003 International Conference on , 20-23 Oct. 2003 □□Pages:311 - 319			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 09/998,400	Applicant(s)/Patent Under Reexamination REED ET AL.	
	Examiner Michael B. Holmes	Art Unit 2121	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	A virtual interface bus for portable PCs Burris, D.; Cargile, F.M.; Dalton, A.; AUTOTESTCON '99: IEEE Systems Readiness Technology Conference, 1999. IEEE , 30 Aug.-2 Sept. 1999 Pages:81 - 86
*	V	Tradeoff decisions made for a P1149.1 controller design [ATE] Vining, S.; Test Conference, 1989. Proceedings. 'Meeting the Tests of Time', International , 29-31 Aug. 1989 Pages:47 - 54
*	W	Hybrid diagnostic strategy for an expert system controlled automatic test system (EXATS) Pflueger, K.W.; Aerospace and Electronic Systems Magazine, IEEE , Volume: 4 , Issue: 10 , Oct. 1989 Pages:25 - 30
*	X	Using neural networks for functional testing Kirkland, L.V.; Wright, R.G.; AUTOTESTCON '95. 'Systems Readiness: Test Technology for the 21st Century'. Conference Record , 8-10 Aug. 1995 Pages:508 - 511

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.